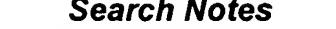


Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/617,252	KIM ET AL.
	Examiner	Art Unit
	Anh T.N. Vo	2861

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner